

PRODUCT/PROCESS CHANGE NOTIFICATION

PCN APG-ABD/13/8027 Dated 08 Aug 2013

VIPower hosed in TO-220,DPAK,D2PK: AI Soft Wire Implementation

Table 1. Change Implementation Schedule

Forecasted implementation date for change	20-Oct-2013
Forecasted availability date of samples for customer	01-Aug-2013
Forecasted date for STMicroelectronics change Qualification Plan results availability	01-Aug-2013
Estimated date of changed product first shipment	25-Oct-2013

Table 2. Change Identification

Product Identification (Product Family/Commercial Product)	see enclosed
Type of change	Package assembly material change
Reason for change	To improve workability and optimization of assembly process
Description of the change	Please be informed that on VIPower products housed in TO-220, D2PAK,DPAK packages AI (Aluminum) soft wire will be implemented replacing the hard one.
Change Product Identification	DataCode
Manufacturing Location(s)	1]St Shenzhen -China

Table	. 2	Liet	٥f	Atta	chn	ante
i abie	· 3.	LIST	OT	Atta	cnn	ients

Customer Part numbers list	
Qualification Plan results	

Customer Acknowledgement of Receipt	PCN APG-ABD/13/8027
Please sign and return to STMicroelectronics Sales Office	Dated 08 Aug 2013
□ Qualification Plan Denied	Name:
□ Qualification Plan Approved	Title:
	Company:
□ Change Denied	Date:
□ Change Approved	Signature:
Remark	
1	

47/.

DOCUMENT APPROVAL

Name	Function
Liporace, Nicola	Marketing Manager
Nicoloso, Riccardo	Product Manager
Minerva, Francesco	Q.A. Manager

47/.



Product Change Notification

VIPower housed in TO-220, DPAK, D2PAK: AI Soft Wire Implementation

INVOLVED P&L FAMILY: 30

WHAT:

We are going to implement AI (Aluminum) soft wire on VIPower products housed in TO-220, DPAK and D2PAK, replacing the hard one.

WHY:

To improve workability and optimization of assembly process.

WHO:

All the Customers that are using VIPower products housed in TO220, DPAK, D2PAK.

WHEN:

Tentative date of change is from October 2013 onward. Sample available on request Qualification report included to this communication.

WHERE:

ST Shenzhen (China) assembly Plant.



Automotive Product Group

Quality and Reliability - Catania Team Reliability Report

Aluminum 10 and 15 mils soft wires Package TO220, DPAK, D2PAK

General Informations

VNB14NV04-E

Commercial Product VND14NV04-E

VNP14NV04-E

Product Line VN78

Silicon process technology VIPower M03

D2PAK

Package DPAK

TO220

Locations

ST CT6 Catania (Italy) **Diffusion fab location**

ST AMK6 Ang Mo Kio

(Singapore)

Assembly plant location

ST Shenzhen (China)

Test plant location

ST Shenzhen (China)

Reliability lab location

ST Shenzhen (China)

Gener	al Informations
Commercial Product	VNP35N07-E

Product Line VN19

Silicon process technology VIPower M02

Package TO220

Locations

Diffusion fab location ST CT6 Catania (Italy) Assembly plant location ST Shenzhen (China) **Test plant location** ST Shenzhen (China) Reliability lab location ST Shenzhen (China)

Revision history

REV.	Date of Release	Author	Changes description
0.1	July 11 th 2013	F.Ceraulo	Creation

Page: 1 of 4



Automotive Product Group Quality and Reliability – Catania Team Reliability Report

Table of contents						
Section Pag Content						
1	3	Reliability evaluations overview				
1.1	3	Objectives				
1.2	3	Results				
2	3	Traceability				
3	4	Reliability qualification plan and results – Summary table				



- 1. Reliability evaluations overview

1.1 Objectives

Aim of this report is to present the results of the reliability evaluations performed on some test vehicles to qualify the Aluminum 10mils and 15mils soft wires for the VIPower products designed in M03 and M02 technology assembled in packages DPAK, D2PAK, TO220.

The chosen test vehicles were the **VNx14NV04-E** (VN78 as ST internal silicon line) and the **VNP35N07-E** (VN19 as ST internal silicon line). The qualification lots were diffused both in ST CT6 Catania (Italy) and ST AMK6 Ang Mo Kio (Singapore) 6" wafer fabs.

The reliability evaluation was performed according to the **AEC_Q100 Rev.G** specification for the package oriented test described in Group A (Accelerated Environment Stress) and Group C (Package Assembly Integrity) using lots with the new soft wires and lots with the hard wires as reference.

1.2 Results

All reliability tests have been completed with positive results, neither functional nor parametric rejects were detected at final electrical testing.

The Device Physical Analysis (DPA) performed on stressed units including the Wire Bond Pull/Shear tests (WBP, WBS) didn't pointed out neither abnormal break loads nor forbidden failure modes.

Based on the overall positive results we consider the products qualified from a reliability point of view.

- 2. Traceability

Package	Device	Diffusion lot	Diffusion fab	Assembly lot		Wire diameter
				Soft wire	Hard wire	
DPAK	VN78	6213VYT	AMK6 (Singapore)	GK22611FZZ	GK22611F01	10 mils
D2PAK	VN78	3201173	CT6 (Catania)	GK22611CZZ	GK22611C01	10 mils
TO220	VN78	6213X01	AMK6 (Singapore)	GK2250KYZR	GK2250KY01	10 mils
10220	VN19	3214756	CT6 (Catania)	GK224072ZY	GK22407202	15 mils

Page: 3 of 4



- 3. Reliability qualification plan and results

AEC #	Test Name	STM Test Conditions	Sample Size/ Lots	Results Fails/SS/Lots	Comments
A1	PC Pre Cond	- Preconditioning according to Jedec JESD22-A113F including 5 Temperature Cycling Ta=-40°C/+60°C - Reflow according to level 3 Jedec JSTD020D-1 - 100 Temperature Cycling Ta=-50°C/+150°C		Before AC, TC	
А3	AC Autoclave	ENV. SEQ. Environmental Sequence TC (Ta=-65°C / +150°C for 100 cycles) + AC (Ta=121°C, Pa=2atm for 96 hours)	77/8	0/77/8	Each assy lot reported in traceability section
A4	TC Temp. Cycling	Ta=-65°C / +150°C for 500 cycles	77/8	0/77/8	Each assy lot reported in traceability section
A6	HTSL High Temp. Storage Life	Ta=150°C for 1000 hours.	77/8	0/77/8	Each assy lot reported in traceability section
C1	WBS Wire Bond Shear		30 bonds from minimum 5 of units from 1 lot	All measurement within spec limits	Each assy lot reported in traceability section
C2	WBP Wire Bond Pull		30 bonds from minimum 5 of units from 1 lot	All measurement within spec limits	Each assy lot reported in traceability section

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY TWO AUTHORIZED ST REPRESENTATIVES, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners

© 2013 STMicroelectronics - All rights reserved.

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

